1.8V / 2.5V 10Gbps Equalizer Receiver with 1:6 Differential CML Outputs

Multi-Level Inputs w/ Internal Termination

Description

The NB7VQ1006M is a high performance differential 1:6 CML fanout buffer with a selectable Equalizer receiver. When placed in series with a Data path operating up to 10 Gb/s, the NB7VQ1006M will compensate the degraded data signal transmitted across a FR4 PCB backplane or cable interconnect and output six identical CML copies of the input signal. Therefore, the serial data rate is increased by reducing Inter–Symbol Interference (ISI) caused by losses in copper interconnect or long cables.

The EQualizer ENable pin (EQEN) allows the IN/ \overline{IN} inputs to either flow through or bypass the Equalizer section. Control of the Equalizer function is realized by setting EQEN; When EQEN is set Low, the IN/ \overline{IN} inputs bypass the Equalizer. When EQEN is set High, the IN/ \overline{IN} inputs flow through the Equalizer. The default state at startup is LOW. As such, the NB7VQ1006M is ideal for SONET, GigE, Fiber Channel, Backplane and other Data distribution applications.

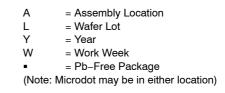
The differential inputs incorporate internal 50 Ω termination resistors that are accessed through the VT pin. This feature allows the NB7VQ1006M to accept various logic level standards, such as LVPECL, CML or LVDS. This feature provides transmission line termination at the receiver, eliminating external components. The outputs have the flexibility of being powered by either a 1.8 V or 2.5 V supply.

The NB7VQ1006M is a member of the GigaComm[™] family of high performance Clock/Data products.

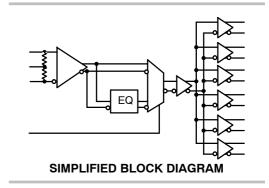
Features

- Maximum Input Data Rate > 10 Gbps
- Maximum Input Clock Frequency > 7.5 GHz
- Backplane and Cable Interconnect Compensation
- 225 ps Typical Propagation Delay
- 30 ps Typical Rise and Fall Times
- Differential CML Outputs, 400 mV Peak-to-Peak, Typical
- Operating Range: $V_{CC} = 1.71$ V to 2.625 V, GND = 0 V
- Internal Input Termination Resistors, 50 Ω
- QFN-24 Package, 4 mm x 4 mm
- -40°C to +85°C Ambient Operating Temperature
- These are Pb-Free Devices*
- *For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.





*For additional marking information, refer to Application Note AND8002/D.



ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 9 of this data sheet.

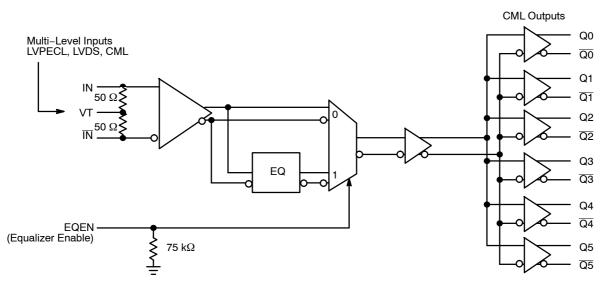




Table 1. EQUALIZER ENABLE FUNCTION

| EQEN | Function |
|------|--|
| 0 | IN/\overline{IN} Inputs Bypass the EQualizer Section |
| 1 | IN/\overline{IN} Inputs Flow through the EQualizer Section |

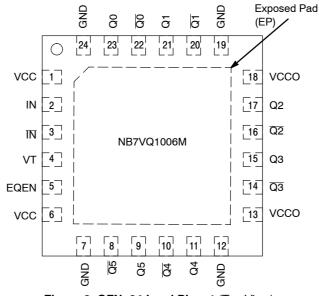


Figure 2. QFN-24 Lead Pinout (Top View)

Table 2. PIN DESCRIPTION

| Pin | Name | I/O | Description |
|-----|-----------|----------------------------|--|
| 1 | VCC | | Positive Supply Voltage for the Core Logic |
| 2 | IN | LVPECL, CML, LVDS Input | Non-inverted Differential Clock/Data Input. (Note 1) |
| 3 | ĪN | LVPECL, CML, LVDS Input | Inverted Differential Clock/Data Input. (Note 1) |
| 4 | VT | | Internal 50 Ω Termination Pin for IN and $\overline{\mathrm{IN}}$ |
| 5 | EQEN | LVCMOS Input | Equalizer Enable Input; pin will default LOW when left open (has internal pull-down resistor) |
| 6 | VCC | | Positive Supply Voltage for the Core Logic |
| 7 | GND | | Negative Supply Voltage |
| 8 | Q5 | CML | Inverted Differential Output. Typically terminated with 50 Ω resistor to V _{CC} . |
| 9 | Q5 | CML | Non-inverted Differential Output. Typically terminated with 50 Ω resistor to V _{CC} . |
| 10 | Q4 | CML | Inverted Differential Output. Typically terminated with 50 Ω resistor to V _{CC} . |
| 11 | Q4 | CML | Non-inverted Differential Output. Typically terminated with 50 Ω resistor to V _{CC} . |
| 12 | GND | | Negative Supply Voltage |
| 13 | VCCO | | Positive Supply Voltage for the pre-amplifier and output buffer |
| 14 | <u>Q3</u> | CML | Inverted Differential Output. Typically terminated with 50 Ω resistor to V _{CC} . |
| 15 | Q3 | CML | Non-inverted Differential Output. Typically terminated with 50 Ω resistor to V _{CC} . |
| 16 | Q2 | CML | Inverted Differential Output. Typically terminated with 50 Ω resistor to V _{CC} . |
| 17 | Q2 | CML | Non-inverted Differential Output. Typically terminated with 50 Ω resistor to V _{CC} . |
| 18 | VCCO | | Positive Supply Voltage for the pre-amplifier and output buffer |
| 19 | GND | | Negative Supply Voltage |
| 20 | Q1 | CML | Inverted Differential Output. Typically terminated with 50 Ω resistor to V _{CC} . |
| 21 | Q1 | CML | Non-inverted Differential Output. Typically terminated with 50 Ω resistor to $V_{CC}.$ |
| 22 | Q0 | CML | Inverted Differential Output. Typically terminated with 50 Ω resistor to V _{CC} . |
| 23 | Q0 | CML | Non-inverted Differential Output. Typically terminated with 50 Ω resistor to $V_{CC}.$ |
| 24 | GND | | Negative Supply Voltage |
| - | EP | - | The Exposed Pad (EP) on the QFN-24 package bottom is thermally connected to the die for im- proved heat transfer out of package. The exposed pad must be attached to a heat-sinking con- duit. The pad is electrically connected to GND and is recommended to be electrically connected to GND on the PC board. |

In the differential configuration when the input termination pin (VT) is connected to a common termination voltage or left open, and if no signal is applied on IN/IN, then the device will be susceptible to self-oscillation.
 All VCC, VCCO and GND pins must be externally connected to the same power supply voltage to guarantee proper device operation.

Table 3. ATTRIBUTES

| Characteristics | | Value | | |
|--|--|----------------------|--|--|
| ESD Protection Human Body Model Machine Model | | > 4 kV > 200 V | | |
| Moisture Sensitivity (Note 3) | | Level 1 | | |
| Flammability Rating Oxygen Index: 28 to 34 | | UL 94 V-0 @ 0.125 in | | |
| Transistor Count | | 244 | | |
| Meets or exceeds JEDEC Spec El | Meets or exceeds JEDEC Spec EIA/JESD78 IC Latchup Test | | | |

3. For additional information, see Application Note AND8003/D.

Table 4. MAXIMUM RATINGS

| Symbol | Parameter | Condition 1 | Condition 2 | Rating | Unit |
|---------------------------------------|---|--------------------|------------------|-------------------------------|--------------|
| V _{CC} , V _{CCO} | Positive Power Supply | GND = 0 V | | 3.0 | V |
| VI | Input Voltage | GND = 0 V | | -0.5 to V _{CC} + 0.5 | V |
| V _{INPP} | Differential Input Voltage IN - IN | | | 1.89 | V |
| I _{IN} | Input Current Through R_T (50 Ω Resistor) | | | ±40 | mA |
| I _{OUT} | Output Current Through R_T (50 Ω Resistor) | | | ±40 | mA |
| T _A | Operating Temperature Range | | | -40 to +85 | °C |
| T _{stg} | Storage Temperature Range | | | -65 to +150 | °C |
| θ_{JA} | Thermal Resistance (Junction-to-Ambient) (Note 4) TGSD 51-6 (2S2P Multilayer Test Board) with Filled Thermal Vias | 0 lfpm 500 lfpm | QFN-24 QFN-24 | 37 32 | °C/W °C/W |
| θ_{JC} | Thermal Resistance (Junction-to-Case) | Standard Board | QFN-24 | 11 | °C/W |
| T _{sol} | Wave Solder Pb-Free | | | 265 | °C |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.
JEDEC standard multilayer board – 2S2P (2 signal, 2 power) with 8 filled thermal vias under exposed pad.

| Symbol | Characteristic | | Min | Тур | Мах | Unit |
|-------------------------------------|---|---|--|--|--|------|
| POWER | SUPPLY CURRENT (Inputs and Outputs open) | | | | | - |
| I _{CC} I _{CCO} | Power Supply Current, Core Logic Power Supply Current, Outputs | $V_{CC} = 2.5V$ $V_{CC} = 1.8V$ $V_{CCO} = 2.5V$ $V_{CCO} = 1.8V$ | | 100 85 180 150 | 115 95 200 175 | mA |
| | TPUTS (Notes 5 and 6) (Figure 10) | | | • | • | |
| V _{OH} | Output HIGH Voltage | V _{CCO} = 2.5 V V _{CCO} = 1.8 V | V _{CCO} – 40 2460 1760 | V _{CCO} – 10 2490 1790 | V _{CCO} 2500 1800 | mV |
| V _{OL} | Output LOW Voltage | $V_{CCO} = 2.5V$ $V_{CCO} = 2.5V$ $V_{CCO} = 1.8V$ $V_{CCO} = 1.8V$ | V _{CCO} - 600 1900 V _{CCO} - 525 1275 | V _{CCO} - 500 2000 V _{CCO} - 425 1375 | $V_{CCO} - 400$ 2100 $V_{CCO} - 300$ 1500 | mV |

| VIHD | Differential Input HIGH Voltage | 1100 | | V _{CC} | mv |
|------------------|---|------|-----|-----------------------|----|
| V _{ILD} | Differential Input LOW Voltage | GND | | V _{CC} – 100 | mV |
| V _{ID} | Differential Input Voltage (V _{IHD -} V _{ILD}) | 100 | | 1200 | mV |
| I _{IH} | Input HIGH Current | -150 | 30 | +150 | μΑ |
| IIL | Input LOW Current | -150 | -40 | +150 | μΑ |

| CONTR | OL INPUTS (EQEN) | | | | |
|-----------------|--------------------|------------------------|----|------------------------|----|
| V_{IH} | Input HIGH Voltage | V _{CC} x 0.65 | | V _{CC} | mV |
| V _{IL} | Input LOW Voltage | GND | | V _{CC} x 0.35 | mV |
| I _{IH} | Input HIGH Current | -150 | 25 | +150 | μΑ |
| IIL | Input LOW Current | -150 | 10 | +150 | μA |
| | | | | | |

TERMINATION RESISTORS

| R _{TIN} | Internal Input Termination Resistor | 45 | 50 | 55 | Ω |
|-------------------|--------------------------------------|----|----|----|---|
| R _{TOUT} | Internal Output Termination Resistor | 45 | 50 | 55 | Ω |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

5. CML outputs loaded with 50 Ω to V_{CC} for proper operation.

6. Input and output parameters vary 1:1 with $V_{CC/}V_{CCO}$. 7. V_{IHD} , V_{ILD} , V_{ID} and V_{CMR} parameters must be complied with simultaneously.

| Symbol | Characteristic | Min | Тур | Max | Unit |
|--|---|--------------------------------|------------------|----------------------|-------|
| f _{DATA} | Maximum Operating Input Data Rate | 10 | | | Gbps |
| f _{MAX} | Maximum Input Clock Frequency V _C V _C | C = 2.5V 7.5 C = 1.8V 6.5 | | | GHz |
| V _{OUTPP} | $ \begin{array}{ll} \mbox{Output Voltage Amplitude EQEN = 0 or 1} & f_{in} \leq 5.0 \mbox{ GHz V}_C \\ \mbox{(See Figures 4, Note 9)} & f_{in} \leq 7.5 \mbox{ GHz V}_C \end{array} $ | C = 2.5V275C = 2.5V225 | 440 360 | | mV |
| | f _{in} ≤ 5 GHz V _C f _{in} ≤ 6.5 GHz V _C | C = 1.8V 225 C = 1.8V 200 | 360 315 | | |
| V _{CMR} | Input Common Mode Range (Differential Configuration, Note 1 | 0) (Figure 8) 1050 | | V _{CC} – 50 | mV |
| t _{PLH} , t _{PHL} | Propagation Delay to Output Differential, IN/IN to Qn/Qn | 170 | 225 | 315 | ps |
| t _{PLH} TC | Propagation Delay Temperature Coefficient -40°C to +85°C | | 30 | | fs/°C |
| t _{DC} | Output Clock Duty Cycle | 48 | 50 | 52 | % |
| t _{SKEW} | Duty Cycle Skew (Note 11) Within Device Skew (Note 12) Device to Device Skew (Note 13) | | 0.15 10 20 | 1 25 40 | ps |
| t _{JITTER} | Random Clock Jitter RJ(RMS), 1000 cycles (Note 14) EQEN = 5 GHz $\leq f_{in} \leq$ | | 0.2 0.2 | 0.7 1.2 | ps |
| | | Gbps 5 = 2.5 V 5 = 1.8 V | 3 3 | 40 20 | |
| V _{INPP} | Input Voltage Swing (Differential Configuration) (Note 16) (Figu | re 6) 100 | | 1200 | mV |
| t _r , t _f | Output Rise/Fall Times Qn/Qn, (20% – 80%) | | 30 | 65 | ps |

| Table 6. AC CHARACTERISTICS $V_{CC} = V_{CCO} = 1.71$ V to 2.625 V; GND = 0 V T _A = -40°C to 85°C (Note 8) |
|---|
|---|

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

Measured using a 400 mV source, 50% duty cycle 1GHz clock source. All outputs must be loaded with external 50 Ω to V_{CCO}. Input edge rates 40 ps (20% – 80%).

9. Output voltage swing is a single-ended measurement operating in differential mode.

10. V_{CMR} min varies 1:1 with GND, V_{CMR} max varies 1:1 with V_{CC}. The V_{CMR} range is referenced to the most positive side of the differential input signal.

11. Duty cycle skew is measured between differential outputs using the deviations of the sum of T_{pw} - and T_{pw} + @ 5 GHz.

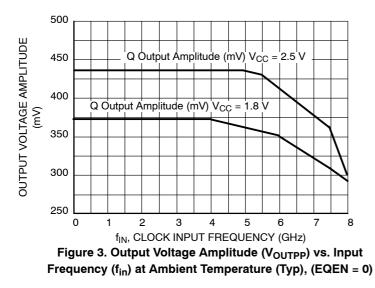
12. Within device skew compares coincident edges.

13. Device to device skew is measured between outputs under identical transition

14. Additive CLOCK jitter with 50% duty cycle clock signal.

15. Additive Peak-to-Peak jitter with input NRZ data at PRBS23.

16. Input voltage swing is a single-ended measurement operating in differential mode, with minimum propagation change of 25 ps.



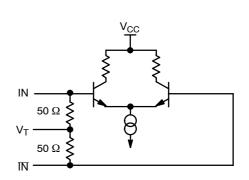
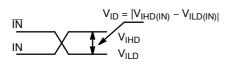


Figure 4. Input Structure



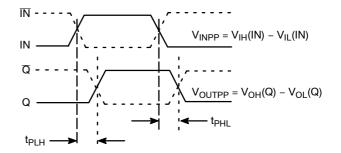




Figure 6. AC Reference Measurement

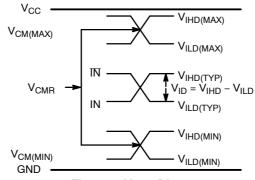


Figure 7. V_{CMR} Diagram

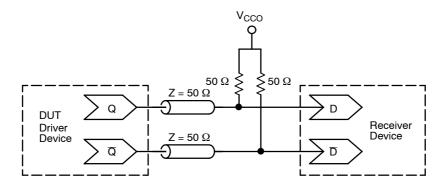
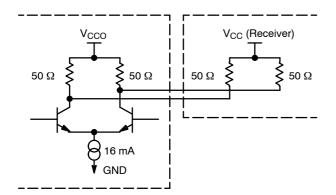
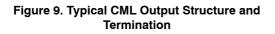
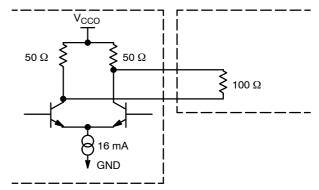


Figure 8. Typical Termination for CML Output Driver and Device Evaluation











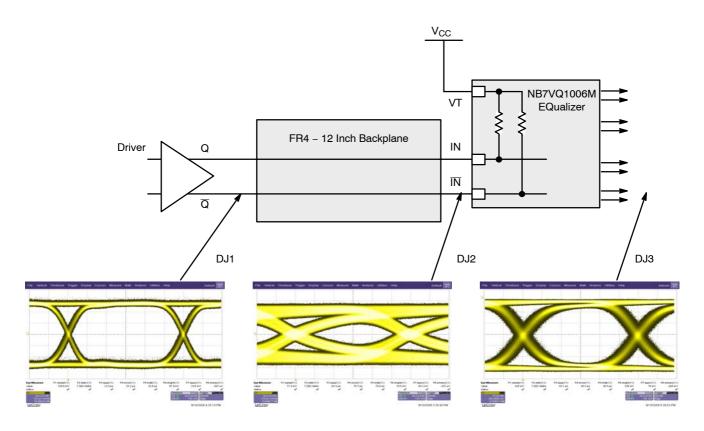
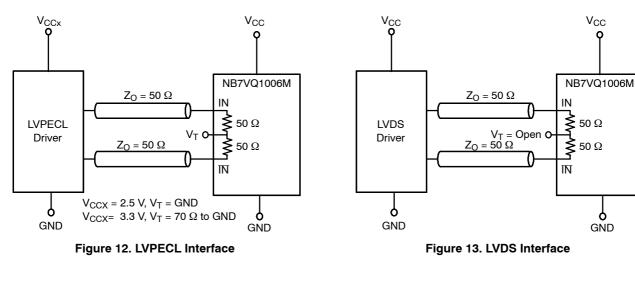


Figure 11. Typical NB7VQ1006 Equalizer Application and Interconnect with PRBS23 pattern at 7.0 Gbps



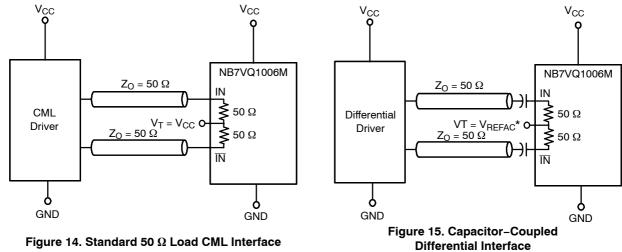


Figure 14. Standard 50 Ω Load CML Interface

(VT Connected to External V_{REFAC})

*V_{REFAC} bypassed to ground with a 0.01 μF capacitor

V_{CC}

50 Ω

50 Ω

Q

GND

 \mathbf{c}

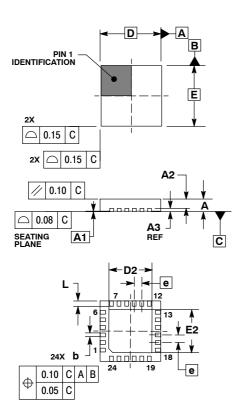
ORDERING INFORMATION

| Device | Package | Shipping [†] |
|------------------|---------------------|-----------------------|
| NB7VQ1006MMNG | QFN-24 (Pb-Free) | 92 Units / Rail |
| NB7VQ1006MMNHTBG | QFN-24 (Pb-Free) | 100 / Tape & Reel |
| NB7VQ1006MMNTXG | QFN-24 (Pb-Free) | 3000 / Tape & Reel |

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

QFN24, 4x4, 0.5P CASE 485L-01 ISSUE A



NOTES: 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

2. CONTROLLING DIMENSION: MILLIMETERS. 3. DIMENSION b APPLIES TO PLATED TERMINAL

- DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 MM FROM TERMINAL.
- 4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

| | MILLIMETERS | | | | |
|-----|-------------|------|--|--|--|
| DIM | MIN MAX | | | | |
| Α | 0.80 | 1.00 | | | |
| A1 | 0.00 | 0.05 | | | |
| A2 | 0.60 | 0.80 | | | |
| A3 | 0.20 REF | | | | |
| b | 0.20 | 0.30 | | | |
| D | 4.00 | BSC | | | |
| D2 | 2.70 | 2.90 | | | |
| Е | 4.00 | BSC | | | |
| E2 | 2.70 | 2.90 | | | |
| е | 0.50 | BSC | | | |
| L | 0.30 | 0.50 | | | |

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